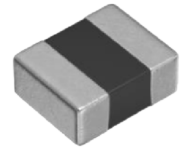


**MLZ2012 Series**  
**Multilayer Chip Power Inductors**
**FEATURES**

- High DC bias current due to developed material
- Low DC resistance
- Low profile and thin thickness
- Monolithic structure for high reliability
- Excellent solderability and high heat resistance
- No cross coupling due to magnetic shield
- Operating Temp. : -40℃~+85℃
- RoHS compliant


**APPLICATIONS**

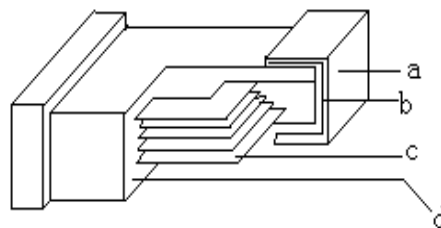
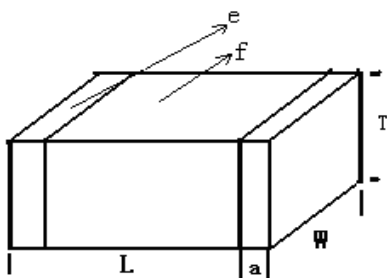
- DC-DC converter circuits for mobile phones, DSCs, DVCs, HDDs, PDAs, etc.

**PRODUCT IDENTIFICATION**

MLZ 2012 A 1R0 M T

1 2 3 4 5 6

- 1:Product Series: Multilayer Chip Power Inductors
- 2:Dimensions:
- 3: Material Code:A,B
- 4:Inductance:1R0=1.0uH
- 5:Tolerance: K±20%
- 6:Packing:Tape Carrier Package

**Dimension & Inner-configuration:**


- a. 镀层 Ni/Sn plating
- b. 银层 Ag layer
- c. 内电极 Inner electrode
- d. 瓷体 Body
- e. 端电极 Terminal electrode
- f. 瓷体 ferrite or ceramic

Unit: mm (inch)

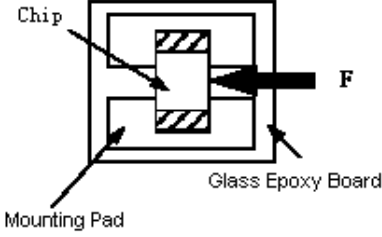
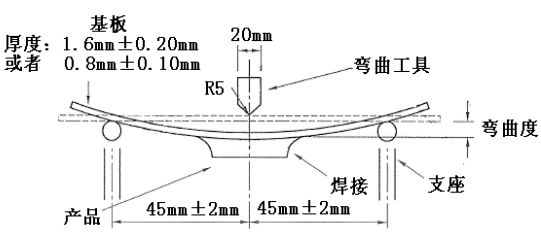
Size	L	W	T	a
201209	2.0±0.20 (0.079±0.008)	1.2±0.20 (0.047±0.008)	0.9±0.20 (0.035±0.008)	0.5±0.3 (0.020±0.012)

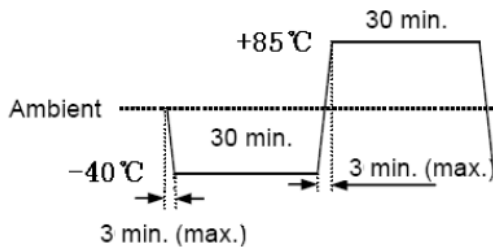
## Electrical Characteristics List

Part NO.	Tolerance (%)	Inductance (μH)	RDC (Ω) max	Test frequency (MHz)	Test voltage (mV)	SRF (MHz) min	Rated current (mA)max
MLZ2012A47NMT	±20	0.047	0.10	1	50	280	1100
MLZ2012A56NMT	±20	0.056	0.10	1	50	280	1100
MLZ2012A68NMT	±20	0.068	0.15	1	50	250	1100
MLZ2012A82NMT	±20	0.082	0.15	1	50	250	1100
MLZ2012AR10MT	±20	0.10	0.15	1	50	210	1100
MLZ2012AR12MT	±20	0.12	0.15	1	50	200	1100
MLZ2012AR15MT	±20	0.15	0.15	1	50	175	1100
MLZ2012AR18MT	±20	0.18	0.15	1	50	160	1100
MLZ2012AR22MT	±20	0.22	0.15	1	50	150	1100
MLZ2012AR27MT	±20	0.27	0.15	1	50	130	1100
MLZ2012AR33MT	±20	0.33	0.15	1	50	120	1100
MLZ2012AR39MT	±20	0.39	0.15	1	50	110	1100
MLZ2012AR47MT	±20	0.47	0.15	1	50	100	1100
MLZ2012AR56MT	±20	0.56	0.36	1	50	100	800
MLZ2012AR68MT	±20	0.68	0.36	1	50	95	800
MLZ2012AR82MT	±20	0.82	0.36	1	50	90	800
MLZ2012A1R0MT	±20	1.0	0.24	1	50	75	800
MLZ2012A1R2MT	±20	1.2	0.24	1	50	65	800
MLZ2012A1R5MT	±20	1.5	0.30	1	50	60	700
MLZ2012A1R8MT	±20	1.8	0.36	1	50	55	600
MLZ2012A2R2MT	±20	2.2	0.36	1	50	50	600
MLZ2012A2R7MT	±20	2.7	0.36	1	50	45	600
MLZ2012A3R3MT	±20	3.3	0.40	1	50	41	350
MLZ2012A3R9MT	±20	3.9	0.40	1	50	38	350
MLZ2012A4R7MT	±20	4.7	0.40	1	50	35	350
MLZ2012A5R6MT	±20	5.6	0.50	1	50	32	250
MLZ2012A6R8MT	±20	6.8	0.50	1	50	29	250
MLZ2012A8R2MT	±20	8.2	0.56	1	50	26	250
MLZ2012A100MT	±20	10	0.56	1	50	24	250
MLZ2012A120MT	±20	12	0.56	1	50	22	250
MLZ2012B150MT	±20	15	0.65	1	50	19	100

## Reliability Testing Items

No.	Items	Requirements	Test Methods and Remarks
1	Operating Temperature Range	-40°C ~ +85°C	
2	Solder ability	At least 95% of terminal electrode should be covered with solder	<p>Preheating temperature: 120°C to 150°C</p> <p>Preheating time: 60s</p> <p>Solder 96.5%Sn/3.0%Ag/0.5%Cu of the Sn solder.</p> <p>Solder temperature: 245 ± 5°C</p> <p>Immersion tin depth: 10mm</p> <p>Duration : 5 ± 1s</p> <p>Dip performance to a flux of about: 3 ~ 5 s</p>
3	Resistance to Soldering	<p>At least 95% of terminal electrode should be covered with solder.</p> <p>No mechanical damage.</p> <p>Inductance :</p> <p>A: change within ± 20%</p> <p>B: change within ± 30%</p>	<p>Preheating temperature: 120°C to 150°C</p> <p>Preheating time: 60s</p> <p>Solder 96.5%Sn/3.0%Ag/0.5%Cu of the Sn solder.</p> <p>Solder temperature: 260°C ± 5°C</p> <p>Immersion tin depth: 10mm</p> <p>Duration : 10 ± 1s</p> <p>Dip performance to a flux of about: 3 ~ 5 s</p>

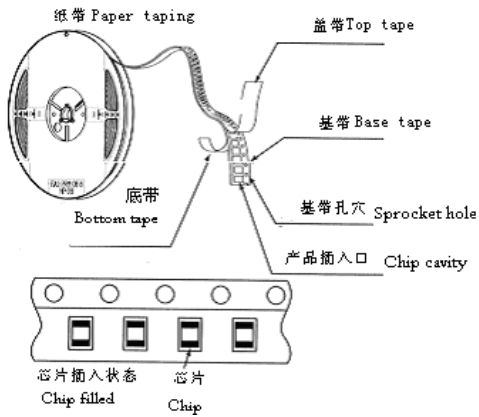
No.	Items	Requirements	Test Methods and Remarks
4	Adhesion of electrode	The termination and body should be no damage.	<p>Applied force: 5N force for 1005 series. Keep time : 10±1S</p>  <p>The diagram shows a cross-section of a chip mounted on a mounting pad on a glass epoxy board. A force F is applied to the chip, pushing it against the pad.</p>
5	Low temperature resistance	<p>No mechanical damage.                      Inductance change: within ± 10%                      Q value change(ferrite): within ± 30%</p>	<p>Temperature: <math>-40 \pm 2^{\circ}\text{C}</math>  <math>+24</math>                      Testing time: <math>1000 \pm 0</math> h</p>
6	Bending strength	No mechanical damage	<p>Testing board: glass epoxy-resin substrate For 0.5 mm/s compression speed, curvature: 2mm, hold time <math>20\text{s} \pm 1\text{s}</math> .</p>  <p>The diagram shows a substrate being bent by a tool. The substrate thickness is 1.6mm ± 0.20mm or 0.8mm ± 0.10mm. The tool has a 20mm span and a 5mm radius (R5). The product is supported by two 45mm ± 2mm segments. The bending tool is labeled '弯曲工具', the product is '产品', the welding is '焊接', and the support is '支座'. The curvature is labeled '弯曲度'.</p>
7	Vibration	<p>No mechanical damage.                      Inductance change: within ± 10%                      Q value change(ferrite): within ± 30%</p>	<p>Amplitude modulation: 1.5mm                      Test time: A period of 2h in each of 3 mutually perpendicular directions.                      Frequency range: 10Hz to 55Hz to 10Hz for 1min.</p>

No.	Items	Requirements	Test Methods and Remarks
8	High temperature resistance	No mechanical damage. Inductance change: within $\pm 10\%$ Q value change(ferrite): within $\pm 30\%$	Testing time: $1000^{+24}_{-0}$ h Temperature: $85 \pm 2^\circ\text{C}$
9	Static Humidity	No mechanical damage. Inductance change: within $\pm 10\%$ Q value change(ferrite): within $\pm 30\%$	Humidity: 90% to 95% RH Temperature: $60^\circ\text{C} \pm 2^\circ\text{C}$ Testing time: $1000^{+24}_{-0}$ h
10	High temperature load	No mechanical damage. Inductance change: within $\pm 10\%$ Q value change(ferrite): within $\pm 30\%$	impose current: at room Testing time: $1000^{+24}_{-0}$ h Temperature: $85 \pm 2^\circ\text{C}$
11	Temperature Shock	No mechanical damage. Inductance change: within $\pm 10\%$ Q value change(ferrite): within $\pm 30\%$	Temperature: $-40^\circ\text{C}$ for $30 \pm 3$ min $+85^\circ\text{C}$ for $30 \pm 3$ min Number of cycles: 32 

**Note: When there are questions concerning, measurement shall be made after  $24 \pm 2$ hrs of recovery under the standard condition.**

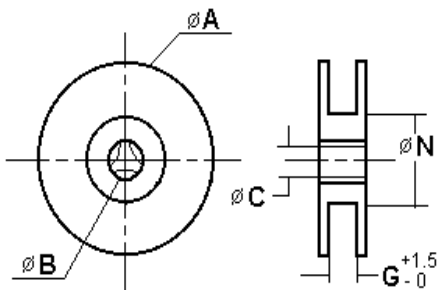
## Packaging

### Taping drawings

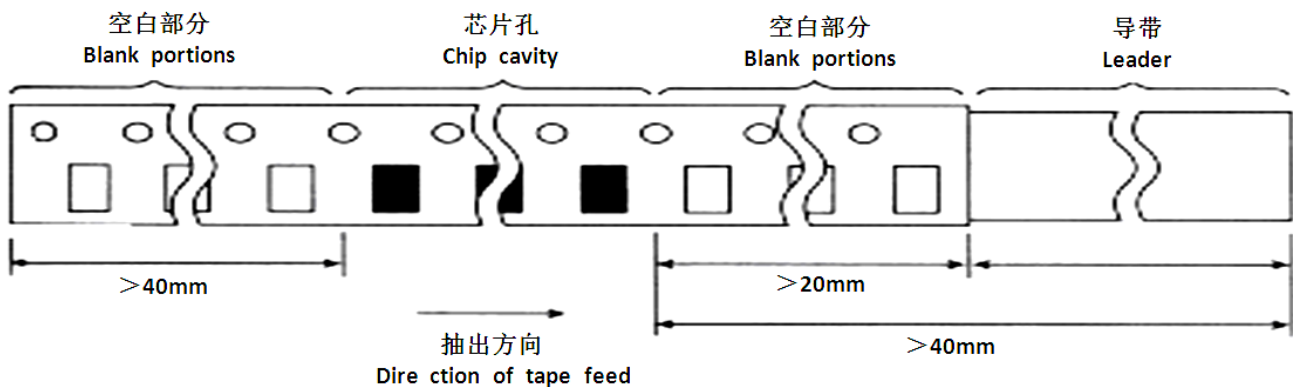


### Reel dimensions (Unit: mm)

Size	A		C	N	G
CF-8	178±2.0	22.0±2.0	12.5±1.5	57±2.0	8

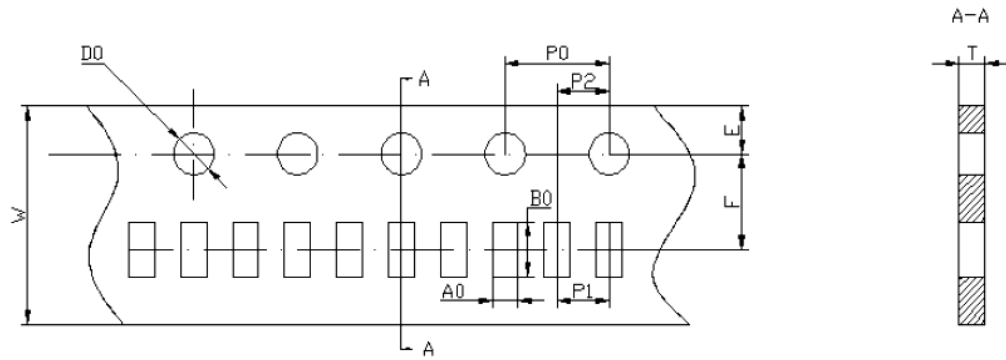


### Leader and blank portion



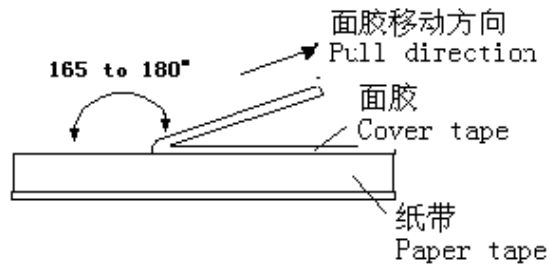
### Taping dimensions (Unit: mm)

- Paper tape



Size	A0	B0	W	F	E	P1	P2	P0	D0	T
201209	1.50±0.2	2.30±0.2	8.0±0.2	3.5±0.1	1.75±0.2	4.0±0.2	2.0±0.1	4.0±0.2	1.55±0.1	0.95±0.1

### Peeling off force



- ① Peeling force should be 0.1~0.7N pulling in the direction of arrow.
- ② Speed of peeling off: 300mm/min.
- ③ The cover bond should not be damaged and bond the tape when it peeled off.

### Packaging number (Unit: Pcs )

Size	201209
REEL	4000
BOX	40000
CASE	240000

## Recommend Soldering Conditions

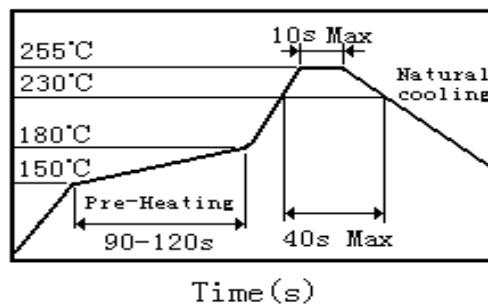
### 1) Soldering Conditions

Products can be applied to reflow soldering.

#### ① Soldering conditions

- Pre-heating should be in such a way that the temperature difference between solder and ferrite surface is limited to 150°C max. Also cooling into solvent after soldering should be in such way that the temperature difference is limited to 100°C max. Un-enough pre-heating may cause cracks on the ferrite, resulting in the deterioration of product quality.
- Products should be soldered within the following allowable range indicated by the slanted line. The excessive soldering conditions may cause the corrosion of the electrode. When soldering is repeated, allowable time is the accumulated time.

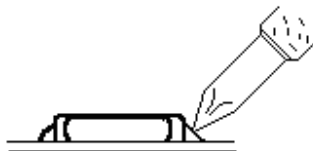
### 2) Reflow soldering profile



### 3) Iron soldering

Perform soldering at 350°C on 30W max.

Soldering Time: < 5S (Take care not to apply the tip of the soldering iron to the terminal electrodes) .





## Cleaning

### 1) Cleaning Conditions

Cleaning temperature : 60°C max

Cleaning time: 1 minute min.

Ultrasonic output power: 200W max

## Storage Requirements

### 1) Storage period

Products which inspected inductor company over 1 year ago should be examined and used, which can be Confirmed with inspection No. marked on the container. Solder ability should be checked if this period is exceeded.

### 2) Storage conditions

(1) Products should be storage in the warehouse on the following conditions:

Temperature : -10~+40°C      Humidity: 30~70% relative humidity

(2) Don't keep products in corrosive gases such as sulfur, chlorine gas or acid , or it may cause oxidization of Electrodes resulting in poor solder ability.

(3) Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.

(4) Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.

(5) Products should be stored under the airtight packaged condition.